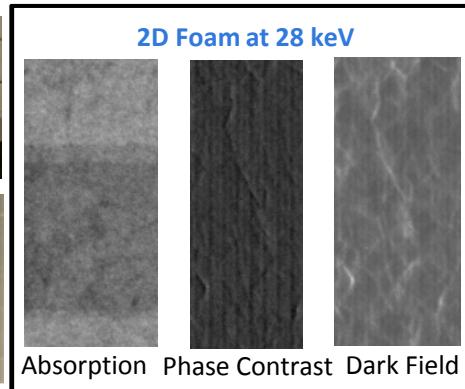
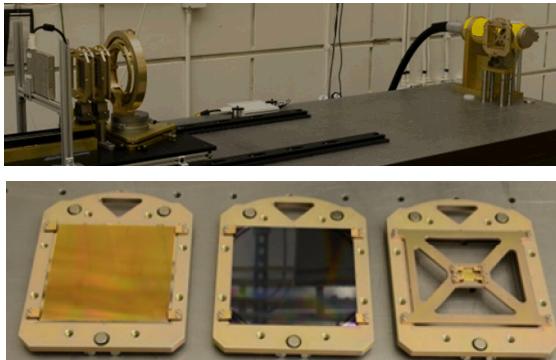


# X-Ray Phase Contrast Imaging (XPCI)

**Problem:** Inspection of internal structure in low density materials

**Goal:** Non-destructive inspection using x-ray phase contrast imaging



## Vision

*XPCI as a state of the art ST&E capability that is widely disseminated and able to rapidly inspect components to assess and mitigate supply chain vulnerabilities; identify defects in low density components with high consequences of failure to improve levels of trust and assurance; employs image processing techniques to differentiate signals of interest*

## R&D Results

- Fabricated unparalleled **large area**, high uniformity, high aspect ratio **gratings** without support structures; **enabling technology** for lab-based XPCI
- Built grating-based XPCI system for 2D acquisition at 28 keV and demonstrated unique information obtained in materials science applications
- Will enable more rapid defect detection in low density materials that do not currently have non-destructive imaging techniques

## R&D Goals

- *Develop a fabrication process for higher aspect ratio gratings to enable higher x-ray energy*
- *Implement 3D tomography and reduce data load through tomosynthesis*
- *Advanced acquisition algorithms and image processing for rapid sample evaluation*

## Significance

- **3 orders of magnitude greater sensitivity** over absorption imaging for low density materials
- **3 complementary imaging modalities; extract more information** about the sample
- **Defect detection** in low density materials that do not currently benefit from **non-destructive** imaging techniques

